

<b>Notice of References Cited</b>		Application/Control No. 09/701,531	Applicant(s)/Patent Under Reexamination DEROWE ET AL.	
		Examiner (Jackie) Tan-Uyen T. Ho	Art Unit 3731	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,951,576	09-1999	Wakabayashi, Akio	606/151
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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